

X Band Driver Amplifier

GaAs Monolithic Microwave IC

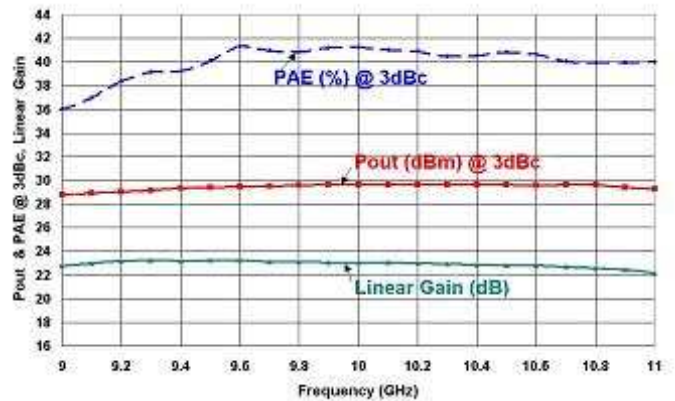
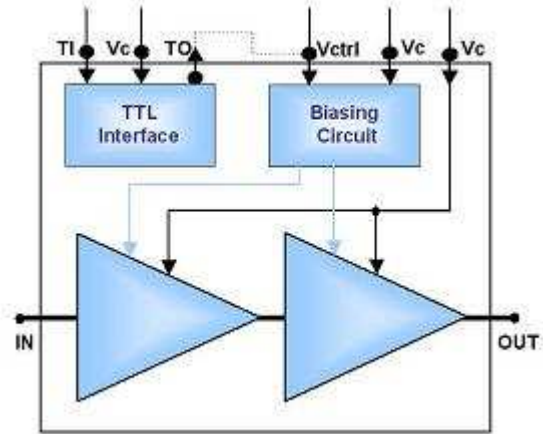
Description

The CHA5012 chip is a monolithic two-stage medium power amplifier designed for X band applications.

This device is manufactured using a GaInP HBT process, including via holes through the substrate and air bridges. A nitride layer protects the transistors and the passive components. Special heat removal techniques are implemented to guarantee high reliability.

To simplify the assembly process:

- the backside of the chip is both RF and DC grounded
- bond pads and back side are gold plated for compatibility with eutectic die attach method and thermosonic or thermocompression bonding process.



Pout & PAE @ 3dB gain compression and Linear Gain (Temperature 25°C)

Main Features

- Frequency band : 9.2-10.8 GHz
- Pout @3dB Gain compression : 29.5 dBm
- P.A.E @3dB Gain Compression : 40 %
- Two biasing modes:
 - Digital control thanks to TTL interface
 - Analog control thanks to biasing circuit
- Chip size: 2.87 x 1.47 x 0.1 mm³

Main Characteristics

Tamb = +25°C, Vc = +7.5V (Pulse 100µs 20%)

Symbol	Parameter	Min	Typ	Max	Unit
Fop	Operating frequency range	9.2		10.8	GHz
G	Small signal gain	21	23		dB
P3dB	Output power at 3dB compression		29.5		dBm
Icq	Power supply quiescent current		200		mA

ESD Protections : Electrostatic discharge sensitive device observe handling precautions

Electrical Characteristics

V_c = +7.5V (Pulse 100µs 20%)

Symbol	Parameter	Min	Typ	Max	Unit
Fop	Operating frequency range	9.2		10.8	GHz
G	Small signal gain at 25°C	21	22.5		dB
ΔG	Small signal gain flatness at 25°C		±0.5		dB
ΔG_T	Linear gain variation vs temperature		-0.025		dB/°C
Pin	Input Power (1)			17	dBm
P1dB	Output power at 1dB gain compression at 25°C		28		dBm
P3dB	Output power at 3dB gain compression at 25°C	27.5	29.5		dBm
	Output power at 3dB gain compression at 80°C	27	29		
PAE_3dBc	PAE at 3dB gain compression at 25°C		40		%
	PAE at 3dB gain compression at 80°C		37		
dBS11	Input Return Loss		-12	-10	dB
dBS22	Output Return Loss		-10	-7	dB
V _c	Power supply voltage		7.5		V
I _{cq}	Power supply quiescent current (2)		200		mA
I _{c_3dBc}	Consumption under 3dB compression		290		mA
V _{ctrl}	Collector current control voltage		5		V
I _{ctrl}	Biasing circuit consumption		5		mA
I _{TI}	TTL input consumption		1		mA
TI _{Low}	TTL input voltage low level		0	0.4	V
TI _{High}	TTL input voltage high level (2)	2.5	5		mA

(1) Output Load 50Ω

(2) For V_c=7.5V, TTL interface settles I_{cq} to 200 mA when TI=TI_{High}. If needed, I_{cq} can be tuned thanks to V_{ctrl} if the analog biasing circuit is used

Absolute Maximum Ratings (3)

T_{amb} = 25°C

Symbol	Parameter	Values	Unit
Top	Operating temperature range	-40 to +80	°C
V _c	Power supply voltage (4)	10	V
I _{cq}	Power supply quiescent current	320	mA
I _{c_sat}	Power supply current in saturation	350	mA
V _{ct}	Collector current control voltage	6.5	V
T _j	Maximum Junction temperature	175	°C
T _{stg}	Storage temperature range	-55 to +125	°C

(3) Operation of this device above anyone of these parameters may cause permanent damage.

(4) Without RF input power

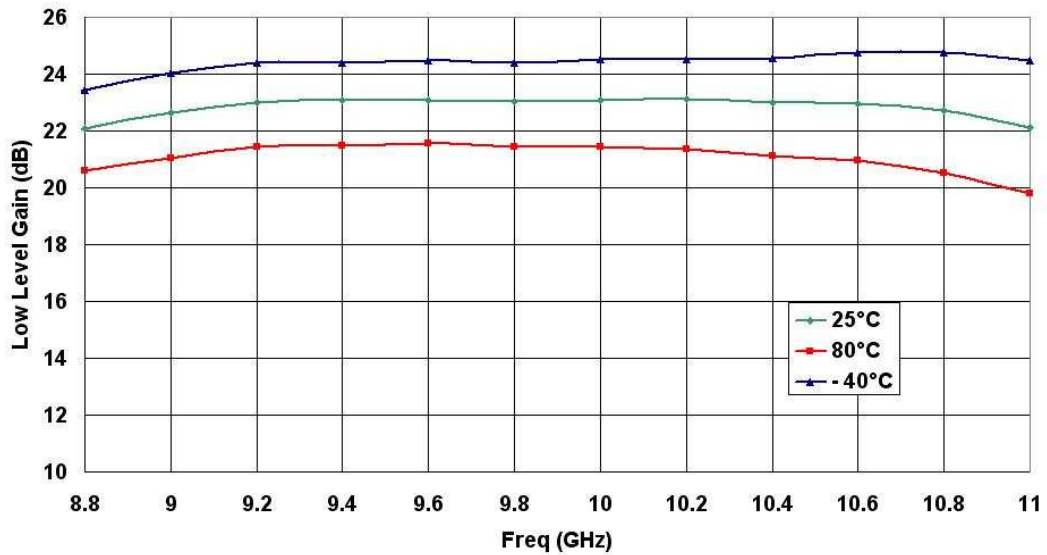
Typical measurement characteristics

Measurement conditions :

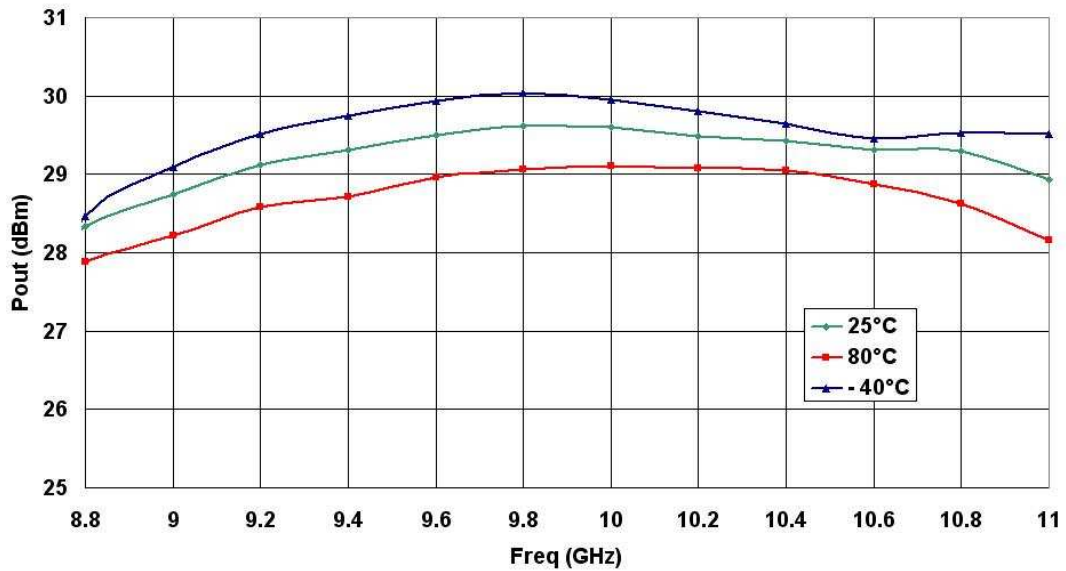
Vc=7.5V

TTL interface used for biasing. TI_High=5V and TI_Low=0V (Ic Quiescent=200mA)

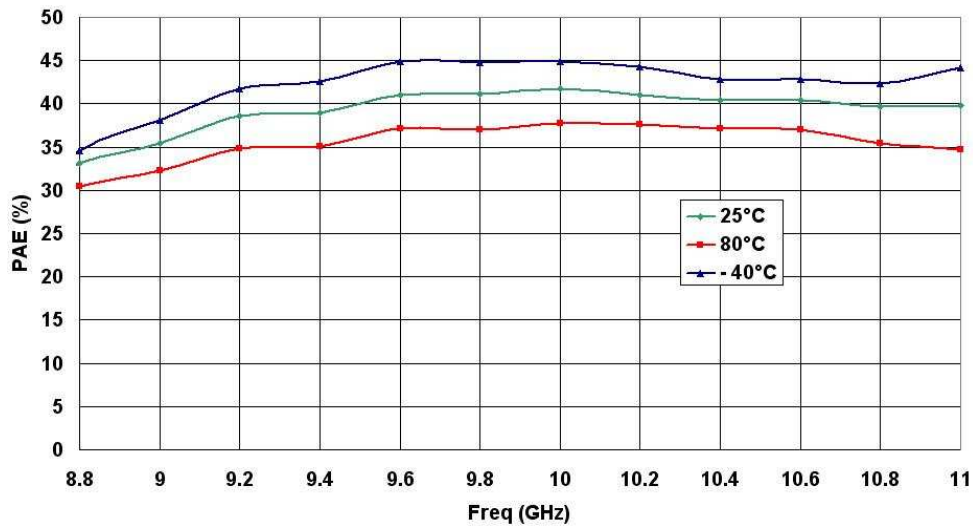
Pulse width=100µs, Duty cycle= 20%



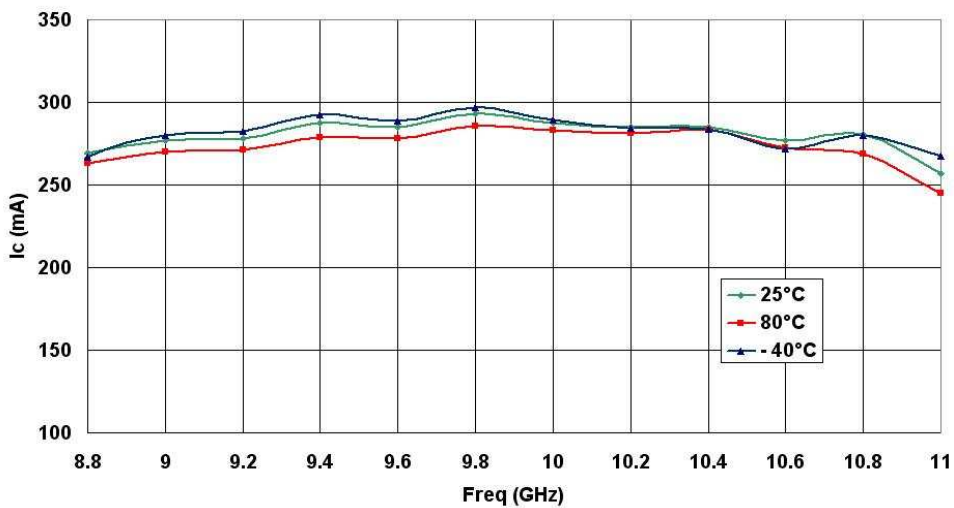
Linear gain versus frequency and temperature



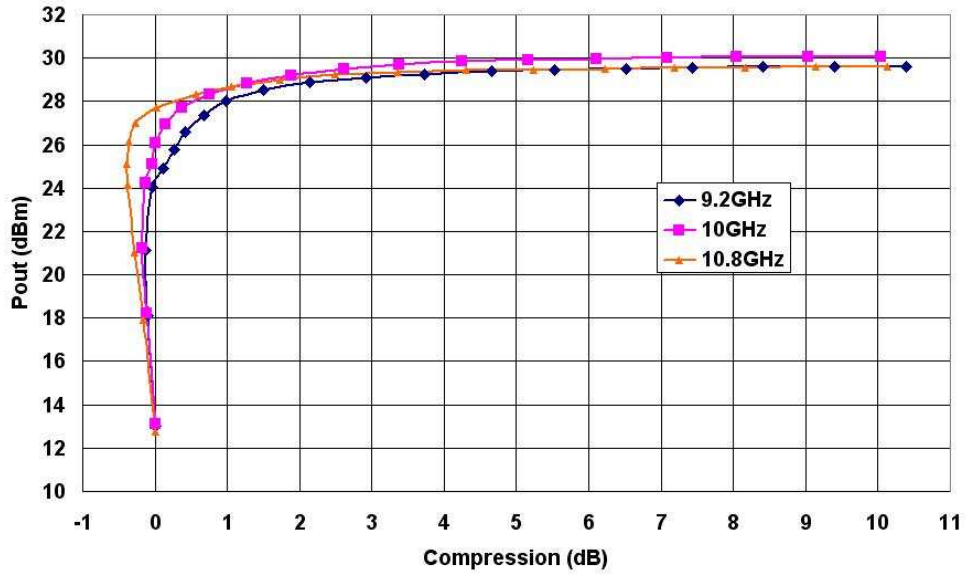
Output power @3dB gain compression versus frequency and temperature



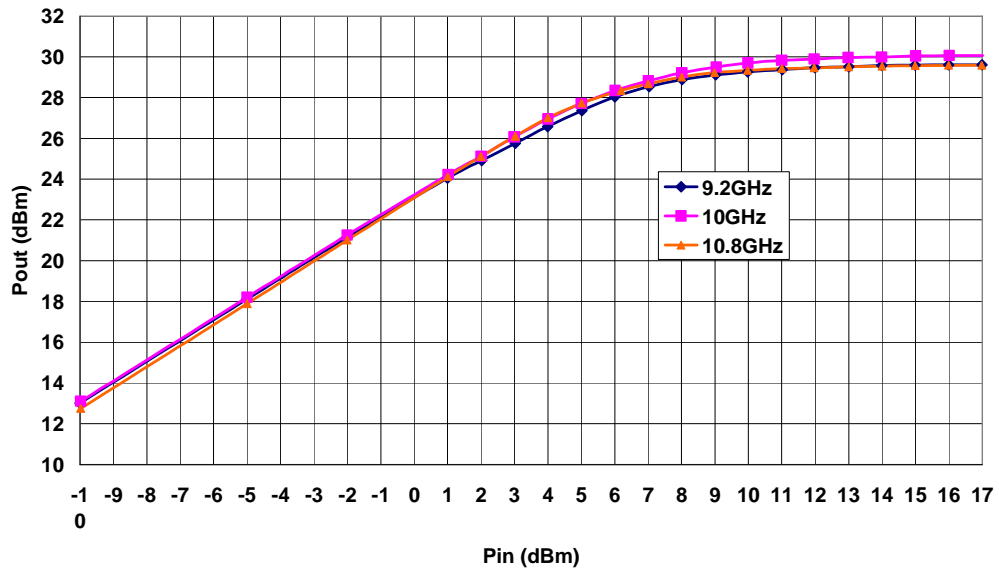
Power added efficiency @3dB gain compression versus frequency and temperature



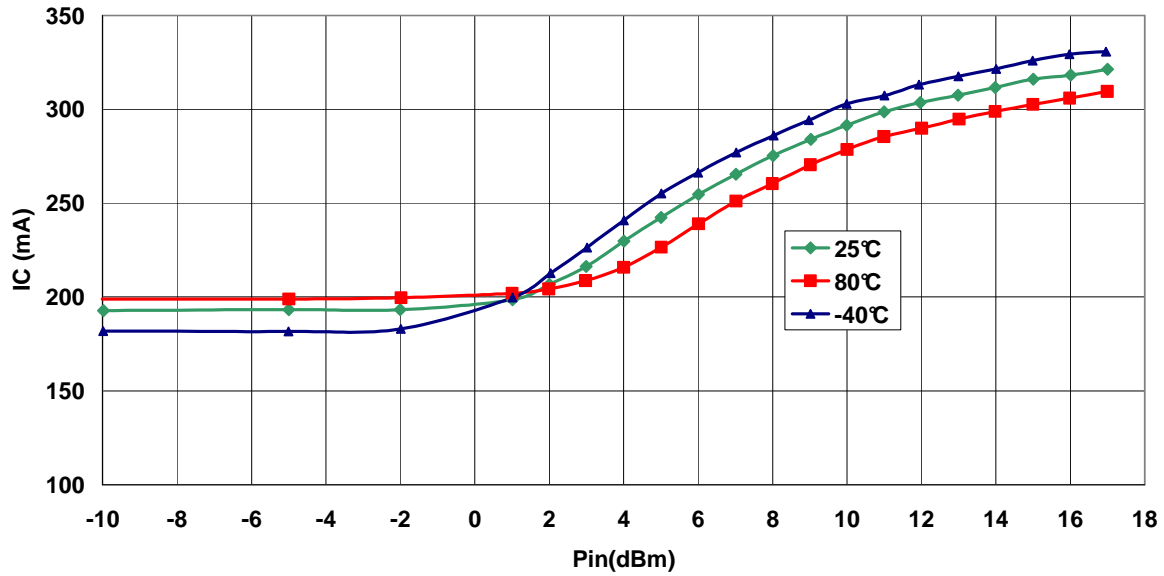
Collector current @3dB gain compression versus frequency and temperature



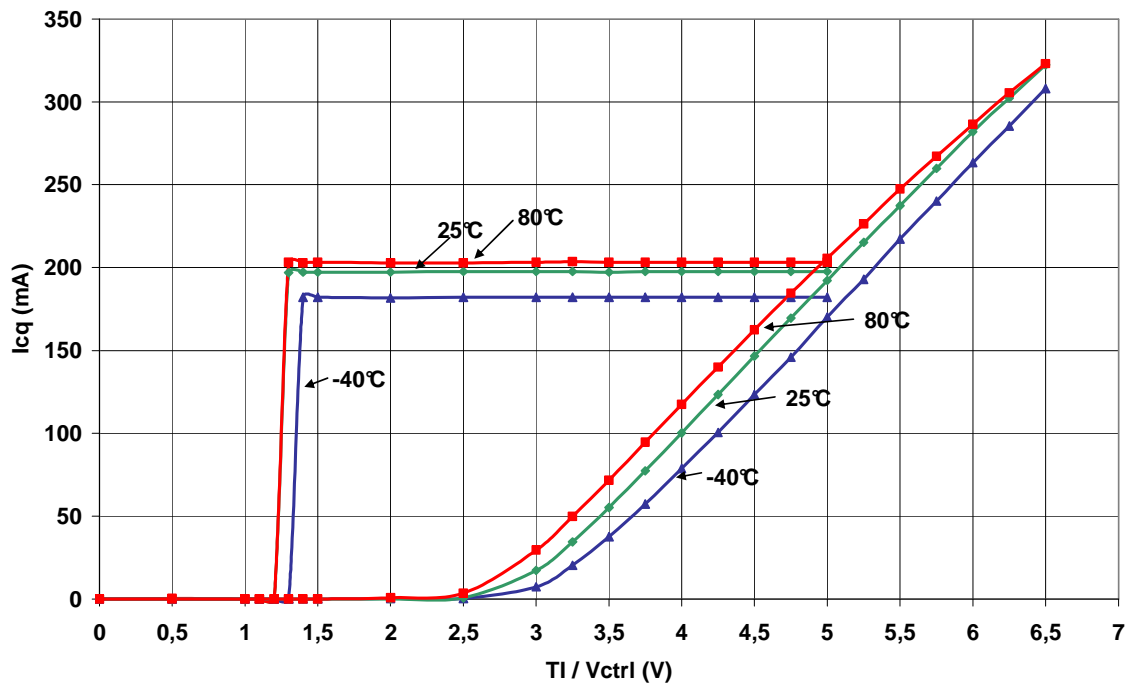
Output power versus gain compression and frequency (Temp.=25°C)



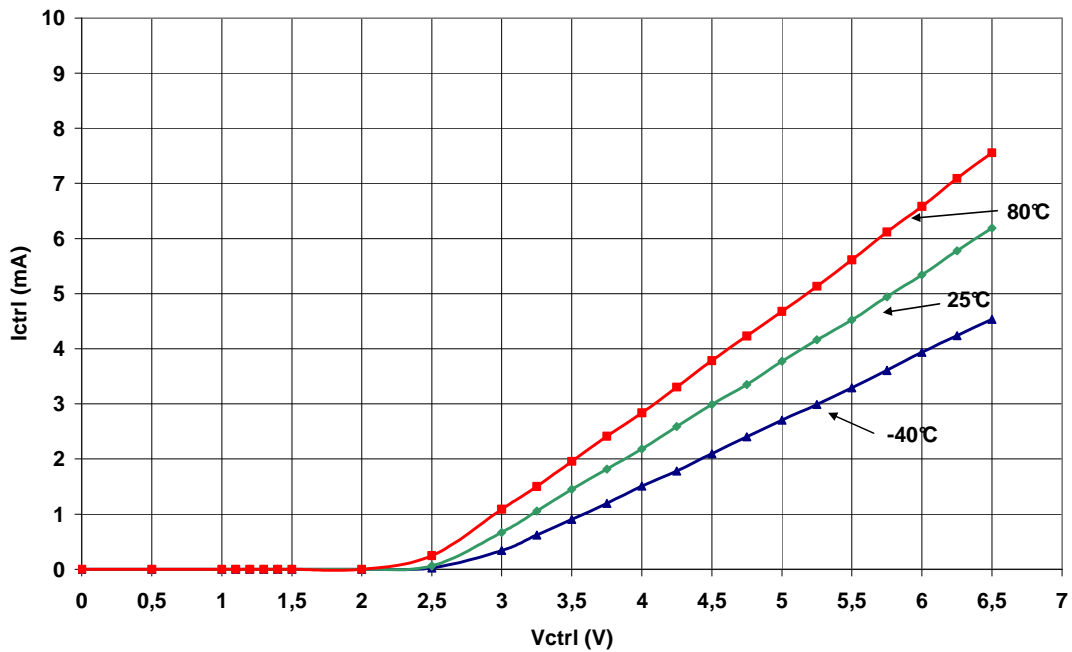
Output power versus Pin and frequency (Temp.=25°C)



Collector current versus input power and temperature @10GHz

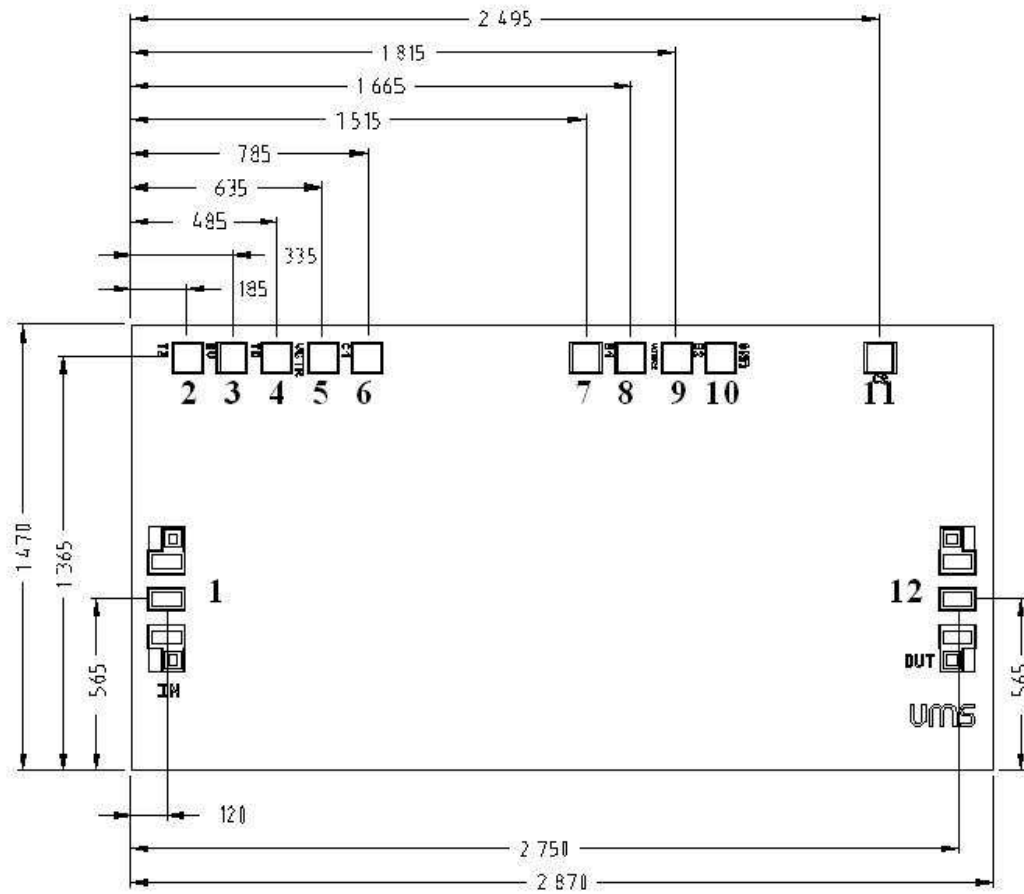


Collector quiescent current versus TI, Vctrl and temperature



Control current versus Vctrl and temperature

Chip Mechanical Data and Pin references



UNITS : μm
 Tol : $\pm 35\mu\text{m}$

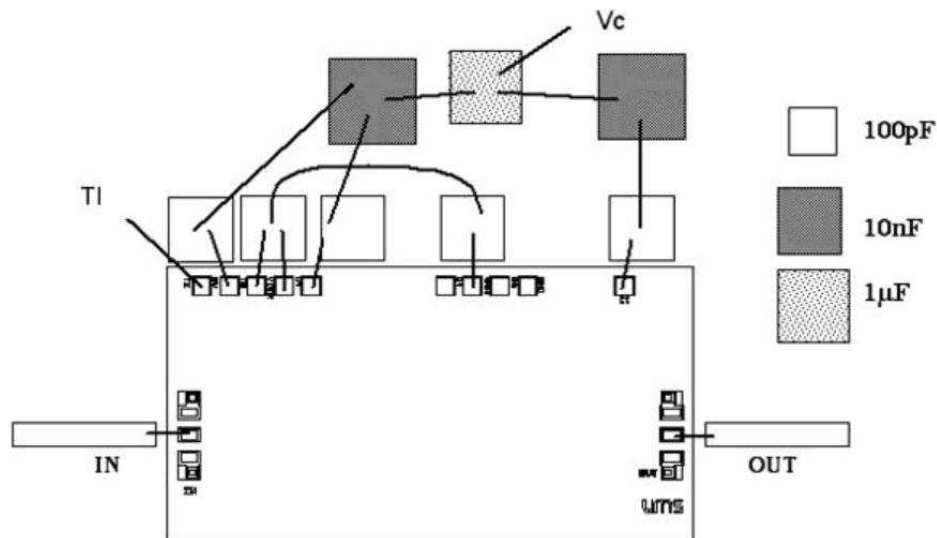
Chip thickness = $100 \pm 10 \mu\text{m}$
 RF pads (1, 12) = $118 \times 68 \mu\text{m}^2$
 DC pads (2, 3, 4, 5, 9, 6, 7, 8, 9, 10, 11) = $96 \times 96 \mu\text{m}^2$

Pin number	Pin name	Description
1	IN	Input RF port
7, 9		NC
5, 8	Vctrl	Collector current control voltage
2	TI	TTL input
4	TO	TTL output
10	GND	Ground (NC)
3, 6, 11	Vc	Power supply voltage
12	OUT	Output RF port

Bonding recommendations

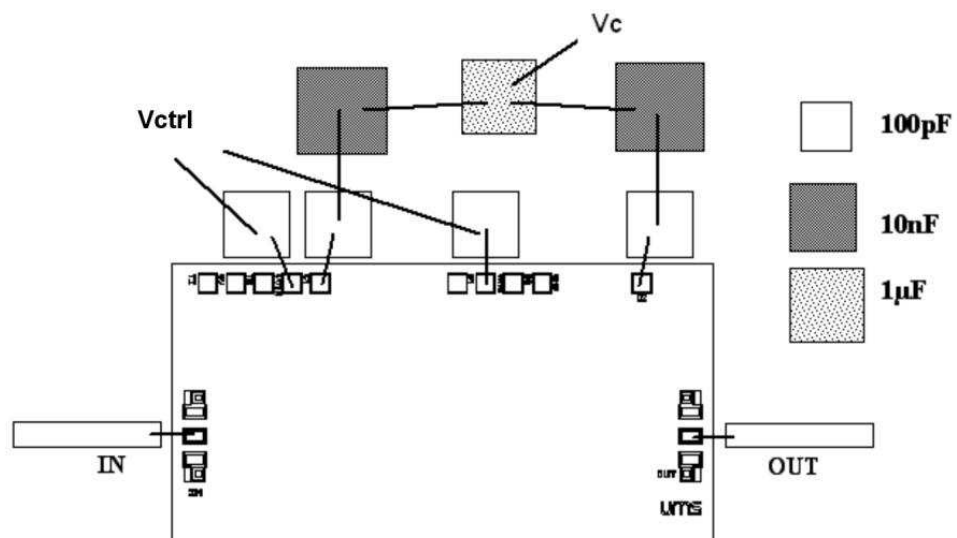
Port	Connection
IN (1)	Inductance ($L_{bonding}$) = 0.3nH 400 μ m length with wire diameter of 25 μ m
OUT (12)	Inductance ($L_{bonding}$) = 0.3nH 400 μ m length with wire diameter of 25 μ m

Assembly recommendations in test fixture using TTL interface



Note: when the TTL interface is used for biasing, the pin TO (pin number 4) must be connected to the pins Vctrl (pins number 5 and 8).

Assembly recommendations in test fixture using analog biasing circuits



Recommended ESD management

Refer to the application note AN0020 available at <http://www.ums-gaas.com> for ESD sensitivity and handling recommendations for the UMS products.

Ordering Information

Chip form : CHA5012-99F/00

Information furnished is believed to be accurate and reliable. However **United Monolithic Semiconductors S.A.S.** assumes no responsibility for the consequences of use of such information nor for any infringement of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of **United Monolithic Semiconductors S.A.S.** Specifications mentioned in this publication are subject to change without notice. This publication supersedes and replaces all information previously supplied. **United Monolithic Semiconductors S.A.S.** products are not authorised for use as critical components in life support devices or systems without express written approval from **United Monolithic Semiconductors S.A.S.**